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PATENT  
ATTORNEY DOCKET NO. 0075/021001

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Detlef KNEBEL et al.

Art Unit: 2878

Application No.: 10/521,563

Examiner:

Title: METHOD FOR LOCALLY HIGHLY RESOLVED, MASS-SPECTROSCOPIC  
CHARACTERIZATION OF SURFACES USING SCANNING PROBE  
TECHNOLOGY

International Application No.: PCT/DE2003/002493

International Filing Date : July 24, 2003

Priority Date : July 24, 2002

U.S. Filing Date : January 19, 2005

**Mail Stop PCT**

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

REQUEST FOR CORRECTED FILING RECEIPT

Sir:

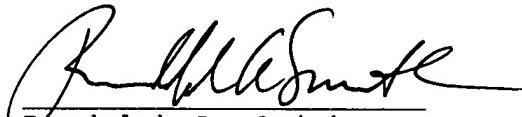
Applicants respectfully request a corrected filing receipt showing one of the applicants' correct residence city and country as follows: Matthias Amrein, Calgary, CANADA. Applicants also respectfully request a corrected filing receipt showing the correct title as follows: METHOD FOR LOCALLY HIGHLY RESOLVED, MASS-SPECTROSCOPIC CHARACTERIZATION OF SURFACES USING SCANNING PROBE TECHNOLOGY. The proposed changes are shown in red on the attached sheet.

REQUEST FOR CORRECTED FILING RECEIPT  
Application No. 10/521,563  
Page 2

In support of this Request, applicants submit a copy of the Declaration that we filed.

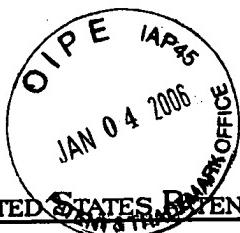
Please telephone the undersigned if there are any questions regarding this request.

Respectfully submitted,

  
\_\_\_\_\_  
Randolph A. Smith  
Reg. No. 32,548

Date: January 4, 2006

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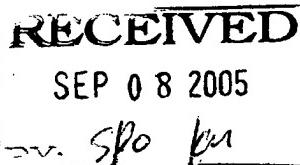


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APPL NO.	FILING OR 371 (c) DATE	ART UNIT	FIL FEE REC'D	ATTY.DOCKET NO	DRAWINGS	TOT CLMS	IND CLMS
10/521,563	08/01/2005	2878	515	0075/021001	2	11	2

Randolph A Smith  
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 1901 Pennsylvania Avenue N W  
 Suite 200  
 Washington, DC 20006-3433



CONFIRMATION NO. 2956  
**FILING RECEIPT**  
 \*OC000000016887436\*  
 \*OC000000016887436\*

Date Mailed: 09/01/2005

Receipt is acknowledged of this regular Patent Application. It will be considered in its order and you will be notified as to the results of the examination. Be sure to provide the U.S. APPLICATION NUMBER, FILING DATE, NAME OF APPLICANT, and TITLE OF INVENTION when inquiring about this application. Fees transmitted by check or draft are subject to collection. Please verify the accuracy of the data presented on this receipt. If an error is noted on this Filing Receipt, please mail to the Commissioner for Patents P.O. Box 1450 Alexandria Va 22313-1450. Please provide a copy of this Filing Receipt with the changes noted thereon. If you received a "Notice to File Missing Parts" for this application, please submit any corrections to this Filing Receipt with your reply to the Notice. When the USPTO processes the reply to the Notice, the USPTO will generate another Filing Receipt incorporating the requested corrections (if appropriate).

**Applicant(s)**

Detlef Knebel, Berlin, GERMANY;  
 Matthias Amrein, Berlin, GERMANY;  
 Calgary, CANADA

**Power of Attorney:**

Randolph Smith-32548

**Domestic Priority data as claimed by applicant**

This application is a 371 of PCT/DE03/02493 07/24/2003

**Foreign Applications**

GERMANY 102 34 507.4 07/24/2002

**Projected Publication Date:** 12/08/2005

**Non-Publication Request:** No

**Early Publication Request:** No

**\*\* SMALL ENTITY \*\***

**Title**

*characterization*

Method for locally highly resolved, mass-spectroscopic *characterisation* of surfaces using scanning probe technology

**Preliminary Class**

250

**PROTECTING YOUR INVENTION OUTSIDE THE UNITED STATES**

Since the rights granted by a U.S. patent extend only throughout the territory of the United States and have no effect in a foreign country, an inventor who wishes patent protection in another country must apply for a patent in a specific country or in regional patent offices. Applicants may wish to consider the filing of an international application under the Patent Cooperation Treaty (PCT). An international (PCT) application generally has the same effect as a regular national patent application in each PCT-member country. The PCT process simplifies the filing of patent applications on the same invention in member countries, but does not result in a grant of "an international patent" and does not eliminate the need of applicants to file additional documents and fees in countries where patent protection is desired.

Almost every country has its own patent law, and a person desiring a patent in a particular country must make an application for patent in that country in accordance with its particular laws. Since the laws of many countries differ in various respects from the patent law of the United States, applicants are advised to seek guidance from specific foreign countries to ensure that patent rights are not lost prematurely.

Applicants also are advised that in the case of inventions made in the United States, the Director of the USPTO must issue a license before applicants can apply for a patent in a foreign country. The filing of a U.S. patent application serves as a request for a foreign filing license. The application's filing receipt contains further information and guidance as to the status of applicant's license for foreign filing.

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Title 37, Code of Federal Regulations, 5.11 & 5.15**

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PATENT  
ATTORNEY DOCKET NO: 0075/021001

## COMBINED DECLARATION AND POWER OF ATTORNEY

As a below named inventor, I hereby declare that:

My residence, post office address and citizenship are as stated below next to my name,

I believe I am the original, first and sole inventor (if only one name is listed below) or an original, first and joint inventor (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled METHOD FOR LOCALLY HIGHLY RESOLVED MASS-SPECTROSCOPIC CHARACTERIZATION OF SURFACES USING SCANNING PROBE TECHNOLOGY, the specification of which

is attached hereto.

was filed on \_\_\_\_\_ as Application Serial No. \_\_\_\_\_

and was amended on \_\_\_\_\_

was described and claimed in PCT International Application No. PCT/DE2003/002493 filed on July 24, 2003 and as amended under PCT Article 19 on \_\_\_\_\_

I hereby state that I have reviewed and understand the contents of the above-identified specification, including the claims, as amended by any amendment referred to above.

I acknowledge the duty to disclose all information I know to be material to patentability in accordance with Title 37, Code of Federal Regulations, Section 1.56.

I hereby claim foreign priority benefits under 35 U.S.C. 119(a)-(d) or 365(b) of any foreign application(s) for patent or inventor's certificate, or 365(a) of any PCT international application which designated at least one country other than the United States of America, listed below and have also identified below, by checking below, any foreign application for patent or inventor's certificate, or of any PCT international application having a filing date before that of the application on which priority is claimed.

<u>102 34 507.4</u>	<u>Germany</u>	<u>July 24, 2002</u>	<u>X</u>	
_____	_____	_____	_____	_____
_____	_____	_____	_____	_____
_____	_____	_____	_____	_____
(Application Number)	(Country)	(Filing Date)	(Priority Claimed)	(Priority Not Claimed)

I hereby appoint the following attorneys and/or agents to prosecute this application and to transact all business in the Patent and Trademark Office connected therewith: Randolph A. Smith, Reg. No. 32,548.

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Address all correspondence to Randolph A. Smith, Smith Patent Office, 1901 Pennsylvania Ave., N.W., Suite 200, Washington, D.C. 20006-3433 (Fax: 202-530-5902)



I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patents issued thereon.

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